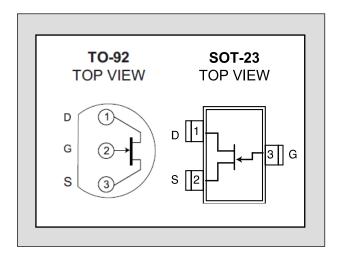


Twenty-Five Years Of Quality Through Innovation

FEATUREO					
FEATURES					
ULTRA LOW NOISE (f=1kHz)	$e_n = 0.9NV/\sqrt{HZ}$				
HIGH BREAKDOWN VOLTAGE	BV _{GSS} =40V max				
HIGH GAIN	Y _{fs} =22mS (typ)				
HIGH INPUT IMPEDENCE	I _G = -500pA max				
LOW CAPACITANCE	22pF max				
IMPROVED SECOND SOURCE REPLACEMENT FOR 2SK170					
ABSOLUTE MAXIMUM RATINGS ¹					
@ 25 °C (unless otherwise stated)					
Maximum Temperatures					
Storage Temperature	-55 to +150 °C				
Operating Junction Temperature	-55 to +135 °C				
Maximum Power Dissipation					
Continuous Power Dissipation@+25°C	400mW				
Maximum Currents					
Gate Forward Current	$I_{G(F)}=10mA$				
Maximum Voltages					
Gate to Source	$V_{GSS} = 40V$				
Gate to Drain	V _{GDS} = 40V				

LSK170 ULTRA LOW NOISE

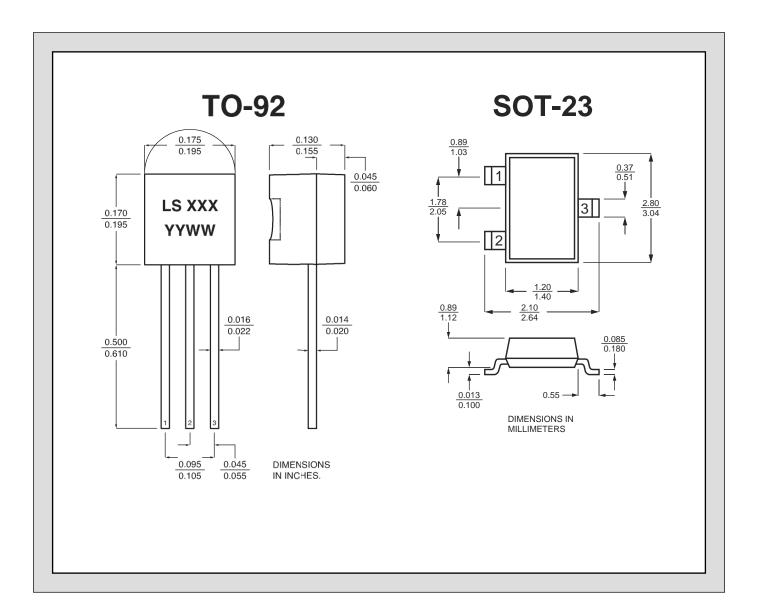
SINGLE N-CHANNEL JFET



*For equivalent monolithic dual, see LSK389 family.

ELECTRICAL CHARACTERISTICS @ 25 °C (unless otherwise stated)

SYMBOL	CHARACTERISTIC			TYP	MAX	UNITS	CONDITIONS	
BV _{GSS}	Gate to Source Breakdown Voltage		-40			V	$V_{DS} = 0$, $I_D = 100 \mu A$	
V _{GS(OFF)}	Gate to Source Pinch-off Voltage		-0.2		-2	V	$V_{DS} = 10V, I_{D} = 1nA$	
V_{GS}	Gate to Source Operating Voltage			0.5		V	$V_{DS} = 10V, I_{D} = 1mA$	
I _{DSS}	Drain to Source Saturation Current	LSK170A	2.6		6.5	mA	$V_{GS} = 10V, \ V_{GS} = 0$	
		LSK170B	6		12			
		LSK170C	10		20			
		LSK170D	18		30			
I _G	Gate Operating Current				-0.5	nA	$V_{DG} = 10V$, $I_D = 1mA$	
I _{GSS}	Gate to Source Leakage Current				-1	nA	$V_{GS} = -10V, \ V_{DS} = 0$	
G_fS	Full Conduction Transconductance			22		mS	$V_{GD} = 10V, V_{GS} = 0, f = 1kHz$	
G_fS	Typical Conduction Transconductance			10		mS	$V_{DG} = 15V$, $I_D = 1mA$	
e _n	Noise Voltage			0.9	1.9	nV/√Hz	$V_{DS} = 10V$, $I_{D} = 2mA$, $f = 1kHz$, $NBW=1Hz$	
en	Noise Voltage			2.5	4	nV/√Hz	$V_{DS} = 10V$, $I_{D} = 2mA$, $f = 10 Hz$, $NBW=1Hz$	
C _{ISS}	Common Source Input Capacitance			20	·	pF	\\ = 15\\ - = 100\\\ f = 1MH\\	
C_{RSS}	Common Source Reverse Transfer Cap.			5		pF	$V_{DS} = 15V$, $I_{D} = 100 \mu A$, $f = 1 MHz$	



- 1. Absolute maximum ratings are limiting values above which serviceability may be impaired.
- 2. Pulse Test: PW ≤ 300µs, Duty Cycle ≤ 3%

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3. All characteristics MIN/TYP/MAX numbers are absolute values. Negative values indicate electrical polarity only.

Linear Integrated Systems (LIS) is a 25-year-old, third-generation precision semiconductor company providing high-quality discrete components. Expertise brought to LIS is based on processes and products developed at Amelco, Union Carbide, Intersil and Micro Power Systems by company President John H. Hall. Hall, a protégé of Silicon Valley legend Dr. Jean Hoerni, was the director of IC Development at Union Carbide, co-founder and vice president of R&D at Intersil, and founder/president of Micro Power Systems.